

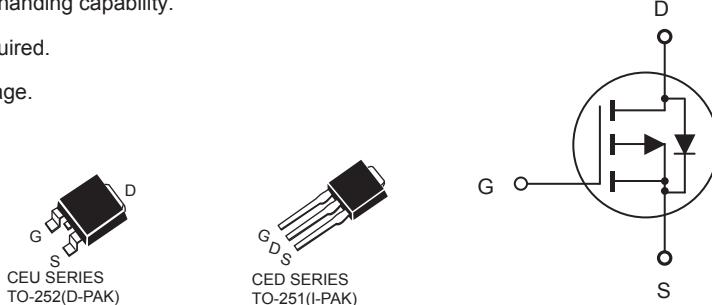


CED4301/CEU4301

P-Channel Enhancement Mode Field Effect Transistor

FEATURES

- -40V, -20A, $R_{DS(ON)} = 42\text{m}\Omega$ @ $V_{GS} = -10\text{V}$.
 $R_{DS(ON)} = 65\text{m}\Omega$ @ $V_{GS} = -4.5\text{V}$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Lead free product is acquired.
- TO-251 & TO-252 package.



ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	-40	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	-20	A
Drain Current-Pulsed ^a	I_{DM}	-80	A
Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$ - Derate above 25°C	P_D	31 0.25	W W/ $^\circ\text{C}$
Operating and Store Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Case	R_{JC}	4	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	R_{JA}	50	$^\circ\text{C/W}$



CED4301/CEU4301

Electrical Characteristics T_A = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = -250µA	-40			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -32V, V _{GS} = 0V			-1	µA
Gate Body Leakage Current, Forward	I _{GSSF}	V _{GS} = 20V, V _{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I _{GSSR}	V _{GS} = -20V, V _{DS} = 0V			-100	nA
On Characteristics^c						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D = -250µA	-1		-3	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = -12A		32	42	mΩ
		V _{GS} = -4.5V, I _D = -8A		50	65	mΩ
Dynamic Characteristics^d						
Forward Transconductance	g _{FS} ^b	V _{DS} = -5V, I _D = -4.8A		12		S
Input Capacitance	C _{iss}	V _{DS} = -20V, V _{GS} = 0V, f = 1.0 MHz		1125		pF
Output Capacitance	C _{oss}			150		pF
Reverse Transfer Capacitance	C _{rss}			100		pF
Switching Characteristics^d						
Turn-On Delay Time	t _{d(on)}	V _{DD} = -20V, I _D = -5A, V _{GS} = -10V, R _{GEN} = 3Ω		12	24	ns
Turn-On Rise Time	t _r			5	30	ns
Turn-Off Delay Time	t _{d(off)}			33	66	ns
Turn-Off Fall Time	t _f			4	8	ns
Total Gate Charge	Q _g	V _{DS} = -20V, I _D = -5A, V _{GS} = -10V		20	26	nC
Gate-Source Charge	Q _{gs}			2.5		nC
Gate-Drain Charge	Q _{gd}			3.5		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current ^b	I _S				-20	A
Drain-Source Diode Forward Voltage ^c	V _{SD}	V _{GS} = 0V, I _S = -1A			-1.3	V

Notes :

- a.Repetitive Rating : Pulse width limited by maximum junction temperature.□
- b.Surface Mounted on FR4 Board, t ≤ 10 sec.□
- c.Pulse Test : Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.□
- d.Guaranteed by design, not subject to production testing.□

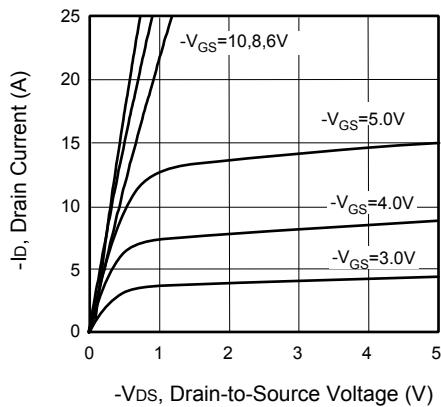


Figure 1. Output Characteristics

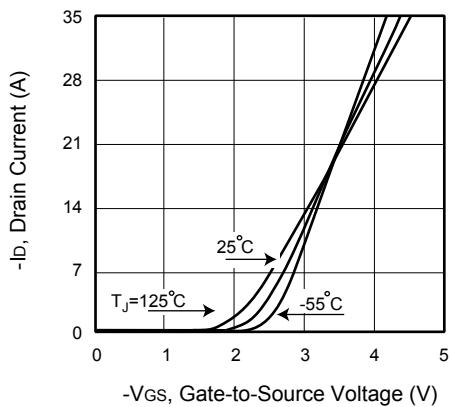


Figure 2. Transfer Characteristics

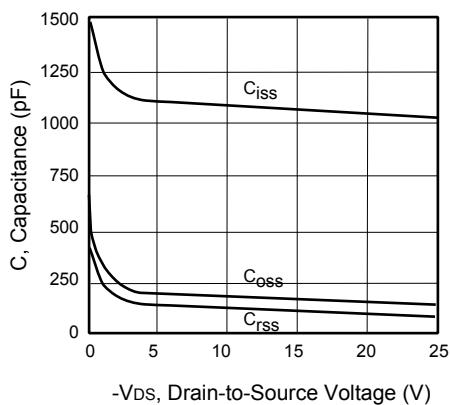


Figure 3. Capacitance

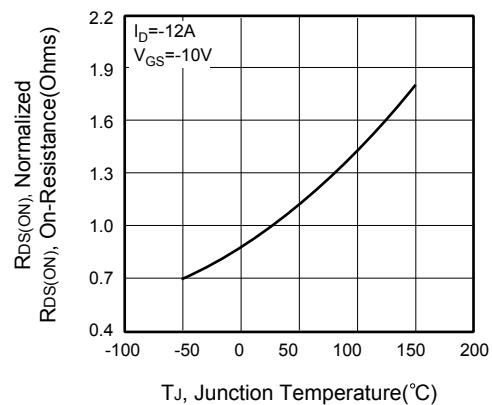


Figure 4. On-Resistance Variation with Temperature

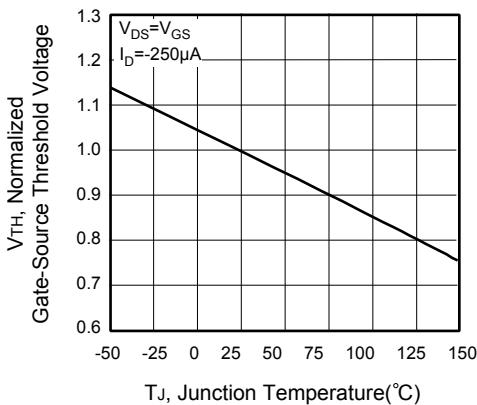


Figure 5. Gate Threshold Variation with Temperature

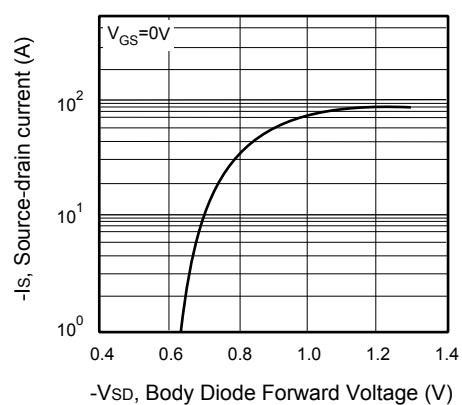


Figure 6. Body Diode Forward Voltage Variation with Source Current

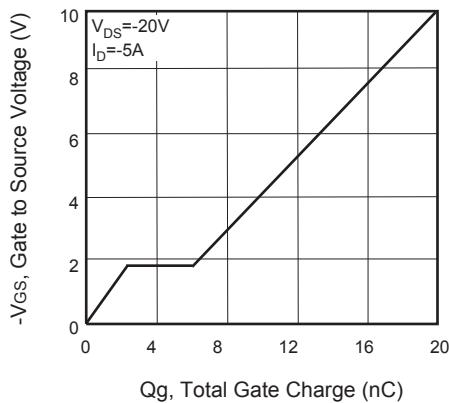


Figure 7. Gate Charge

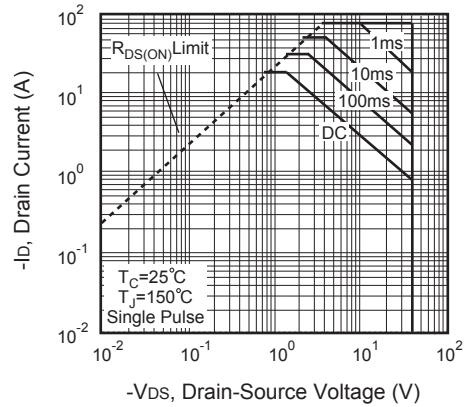


Figure 8. Maximum Safe Operating Area

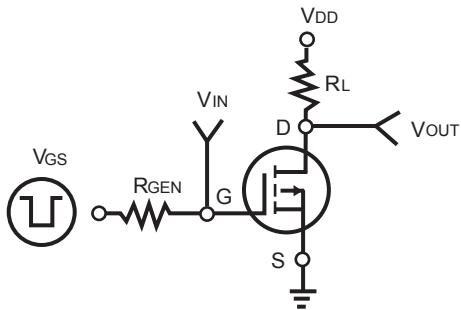


Figure 9. Switching Test Circuit

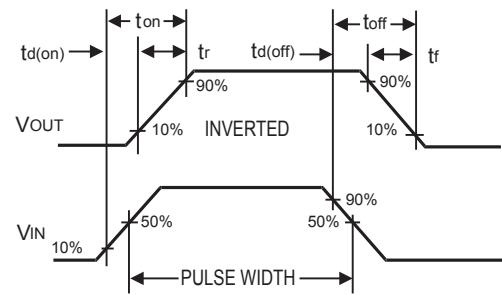


Figure 10. Switching Waveforms

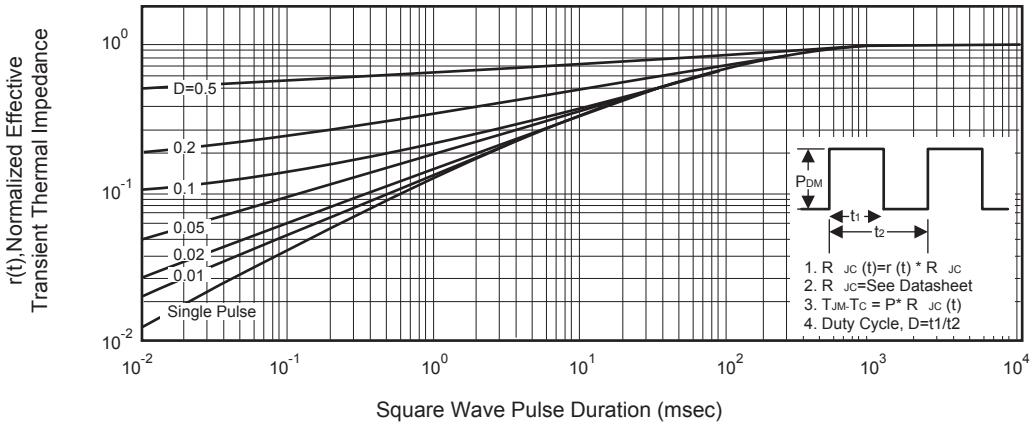


Figure 11. Normalized Thermal Transient Impedance Curve